

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/612,398 | Applicant(s)/Patent Under Reexamination AHOLAINEN ET AL. | |
| | Examiner Dai A Phuong | Art Unit 2685 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| | A | US-6,119,003 A | 09-2000 | Kukkohovi, Marko | 455/435.2 |
| | B | US-2004/0243684 A1 | 12-2004 | Ha et al. | 709/208 |
| | C | US-2004/0202187 A1 | 10-2004 | Kelly et al. | 370/401 |
| | D | US-2005/0037755 A1 | 02-2005 | Hind et al. | 455/435.3 |
| | E | US-2005/0003816 A1 | 01-2005 | Vardoulis et al. | 455/435.2 |
| | F | US-2004/0203354 A1 | 10-2004 | Yue, Lin | 455/041.1 |
| | G | US-2003/0060168 A1 | 03-2003 | Teibel, Daniel A. | 455/69 |
| | H | US-2003/0214940 A1 | 11-2003 | Takken, Todd E. | 370/352 |
| | I | US-2003/0055912 A1 | 03-2003 | MARTIN et al. | 709/218 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.